

Search Notes

Application/Control No.

10/817,572

Examiner

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Applicant(s)/Patent under
Reexamination

LISSEL ET AL.

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
710	5-7, 20-28, 33-35, 52- 57	9/15/2006	CS
710	308-310	9/15/2006	CS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
710	22, 52	9/16/2006	CS
710	308, 310	9/16/2006	CS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PLUS	9/15/2006	CS
PALM	9/15/2006	CS
EAST (EPO, JPO, DERWENT, IBMTDB, USOCR, USPAT, USPGPUB)	9/15/2006	CS